Se	arch N	lotes	

Application/Control No.	Applicant(s)/Patent under Reexamination	•
10/761,619	AOKI ET AL.	
Examiner	Art Unit	
Derek I Dunuis	2883	

SEARCHED			
Class	Subclass	Date	Examiner
385	140	12/1/2005	DLD
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INTERFERENCE SEARCHED			
Class	Subclass	Date -	Examiner
385	8,40,140	12/1/2005	DLD
1	xt search in ST	12/1/2005	DLD

SEARCH NOTES (INCLUDING SEARCH STRATEGY)			
	DATE	EXMR	
BRS search in EAST (USPAT, USPGPUB, USOCR, EPO, JPO, DERWENT, IBM_TDB) - see attached search history printout	12/1/2005	DLD	
Limited classification search: 385/4,8- 10,39-41,48,140; - see attached search history printout	11/30/2005	DLD	
Inventor name search - see attached printout	12/1/2005	DLD	
NPL search in IEEE Explore - see attached printout	12/1/2005	DLD	
Consulted Kaveh Kianni on search strategy	11/30/2005	DLD	